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## WHAT IS CLAIMED IS:

- 1. A polishing composition comprising:
  - (a) silica abrasive,
  - (b) methanol, and
  - (c) a liquid carrier,

wherein the polishing composition has a pH of about 1 to about 6 and the interaction between the silica abrasive and the methanol provides colloidal stability to the polishing composition.

- 2. The polishing composition of claim 1, wherein the silica abrasive is selected from the group consisting of fumed silica, colloidal silica, silica-coated abrasive particles, and combinations thereof.
- 3. The polishing composition of claim 1, wherein the polishing composition has a pH of about 1.5 to about 4.
- 4. The polishing composition of claim 1, wherein the liquid carrier comprises water.
- 5. The polishing composition of claim 1, wherein the methanol is present in an amount of about 100 ppm to about 1500 ppm.
- 6. The polishing composition of claim 5, wherein the methanol is present in an amount of about 100 ppm to about 800 ppm.
- 7. The polishing composition of claim 1, wherein the silica abrasive is present in an amount of about 0.5 wt.% to about 5 wt.%.
- 8. The polishing composition of claim 5, wherein about 200 ppm to about 3000 ppm of methanol is present per wt.% of silica abrasive.
- 9. The polishing composition of claim 6, wherein about 200 ppm to about 1600 ppm of methanol is present per wt.% of silica abrasive.
- 10. The polishing composition of claim 1, wherein the composition further comprises an oxidizer.
- 11. The polishing composition of claim 1, wherein the composition further comprises a complexing agent.

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12. A method of polishing a substrate comprising (i) contacting a substrate comprising a silicon-based layer with the polishing composition of claim 1, and (ii) abrading at least a portion of the substrate with the polishing composition to polish the substrate.

- 13. The method of claim 12, wherein the substrate further comprises a tungsten layer.
- 14. The method of claim 12, wherein the substrate further comprises a copper or nickel layer.
- 15. The method of claim 12, wherein the silicon-based layer is silicon dioxide and the substrate further comprises a silicon nitride layer.
- 16. A method of stabilizing a polishing composition comprising a silica abrasive and a liquid carrier comprising (i) providing silica abrasive, (ii) providing a liquid carrier for the silica abrasive, and (iii) contacting the silica abrasive with methanol to form a stabilized polishing composition.
- 17. The method of claim 16, wherein the polishing composition has a pH of about 1 to about 6.